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16-Kb Microwire Serial **EEPROM**

Description

The CAT93C86B is a 16–Kb Serial EEPROM memory device which is configured as either registers of 16 bits (ORG pin at V_{CC}) or 8 bits (ORG pin at GND). Each register can be written (or read) serially by using the DI (or DO) pin. The CAT93C86B features a self–timed internal write with auto–clear. On–chip Power–On Reset circuit protects the internal logic against powering up in the wrong state.

Features

- High Speed Operation: 4 MHz (5 V), 2 MHz (1.8 V)
- 1.8 V (1.65 V*) to 5.5 V Supply Voltage Range
- Selectable x8 or x16 Memory Organization
- Self-timed Write Cycle with Auto-clear
- Sequential Read
- Hardware and Software Write Protection
- Power-up Inadvertent Write Protection
- Low Power CMOS Technology
- Program Enable (PE) Pin
- 1,000,000 Program/Erase Cycles
- 100 Year Data Retention
- Industrial and Extended Temperature Ranges
- 8-pin PDIP, SOIC, MSOP, TSSOP, 8-pad UDFN, and WLCSP 6-ball Packages
- This Device is Pb–Free, Halogen Free/BFR Free, and RoHS Compliant[†]

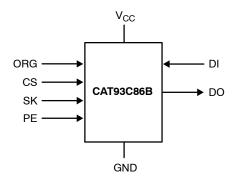


Figure 1. Functional Symbol

*CAT93C86Bxx-xxL ($T_{\Delta} = -20^{\circ}\text{C to } +85^{\circ}\text{C}$)

†For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



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PDIP-8

L SUFFIX

CASE 646AA





SOIC-8 X SUFFIX CASE 751BE



HU4 SUFFIX CASE 517AZ



WLCSP-6 C6A SUFFIX PRELIMINARY



TSSOP-8
Y SUFFIX
CASE 948AL

SOIC-8 V SUFFIX CASE 751BD

PIN CONFIGURATION

CS 1 V_{CC}
SK PE
DI ORG
DO GND

PDIP (L), SOIC (V, X), TSSOP (Y), UDFN (HU4), MSOP (Z)



WLCSP*, ** (C6A)
*ORG internally
connected to GND
**PE float

PIN FUNCTION

Pin Name	Function	
CS	Chip Select	
SK	Clock Input	
DI	Serial Data Input	
DO	Serial Data Output	
V _{CC}	Power Supply	
GND	Ground	
ORG	Memory Organization	
PE	Program Enable	

Note: When the ORG pin is connected to V_{CC} , the x16 organization is selected. When it is connected to ground, the x8 pin is selected. If the ORG pin is left unconnected, then an internal pull–up device will select the x16 organization.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 14 of this data sheet.

Table 1. ABSOLUTE MAXIMUM RATINGS

Parameters	Ratings	Units
Storage Temperature	-65 to +150	°C
Voltage on Any Pin with Respect to Ground (Note 1)	-0.5 to +6.5	V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Table 2. RELIABILITY CHARACTERISTICS (Note 2)

Sym	nbol	Parameter	Min	Units
N _{END} (I	(Note 3)	Endurance	1,000,000	Program / Erase Cycles
T	DR	Data Retention	100	Years

^{2.} These parameters are tested initially and after a design or process change that affects the parameter according to appropriate AEC-Q100 and JEDEC test methods.

Table 3. D.C. OPERATING CHARACTERISTICS

 $(V_{CC} = +1.8 \text{ V to } +5.5 \text{ V}, T_A = -40 ^{\circ}\text{C to } +125 ^{\circ}\text{C}, V_{CC} = +1.65 \text{ V to } +5.5 \text{ V}, T_A = -20 ^{\circ}\text{C to } +85 ^{\circ}\text{C unless otherwise specified.})$

Symbol	Parameter	Test Cor	nditions	Min	Max	Units
I _{CC1}	Supply Current (Write)	Write, V _{CC} = 5.0 V			2	mA
I _{CC2}	Supply Current (Read)	Read, DO open, f _{SK} = 2 MH:	z, V _{CC} = 5.0 V		500	μΑ
I _{SB1}	Standby Current	$V_{IN} = GND \text{ or } V_{CC}$ $T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$			2	μΑ
	(x8 Mode)	CS = GND, ORG = GND	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		5	
I _{SB2}	Standby Current	V _{IN} = GND or V _{CC}	$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$		1	μΑ
	(x16 Mode)	CS = GND, ORG = Float or V _{CC}	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		3	
ILI	Input Leakage Current	V _{IN} = GND to V _{CC}	$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$		1	μΑ
			$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		2	
I _{LO}	Output Leakage	V _{OUT} = GND to V _{CC}	$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$		1	μΑ
	Current	CS = GND	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		2	
V _{IL1}	Input Low Voltage	4.5 V ≤ V _{CC} < 5.5 V		-0.1	0.8	V
V _{IH1}	Input High Voltage	4.5 V ≤ V _{CC} < 5.5 V		2	V _{CC} + 1	V
V_{IL2}	Input Low Voltage	1.65 V ≤ V _{CC} < 4.5 V		0	V _{CC} x 0.2	V
V _{IH2}	Input High Voltage	1.65 V ≤ V _{CC} < 4.5 V		V _{CC} x 0.7	V _{CC} + 1	V
V _{OL1}	Output Low Voltage	4.5 V ≤ V _{CC} < 5.5 V, I _{OL} = 3 mA			0.4	V
V _{OH1}	Output High Voltage	$4.5~V \le V_{CC} < 5.5~V$, $I_{OH} = -400~\mu A$		2.4		V
V _{OL2}	Output Low Voltage	$1.65 \text{ V} \le \text{V}_{CC} < 4.5 \text{ V}, \text{I}_{OL} = 1 \text{ mA}$			0.2	V
V _{OH2}	Output High Voltage	1.65 V ≤ V _{CC} < 4.5 V, I _{OH} =	–100 μΑ	V _{CC} - 0.2		V

Table 4. PIN CAPACITANCE (Note 4)

Symbol	Test	Conditions	Min	Тур	Max	Units
C _{OUT}	Output Capacitance (DO)	V _{OUT} = 0 V			5	pF
C _{IN}	Input Capacitance (CS, SK, DI, ORG)	V _{IN} = 0 V			5	pF

Table 5. POWER-UP TIMING (Notes 4, 5)

Symbol Parameter		Max	Units
t _{PUR}	Power-up to Read Operation	1	ms
t _{PUW} Power-up to Write Operation		1	ms

^{1.} The DC input voltage on any pin should not be lower than -0.5 V or higher than $V_{CC} + 0.5$ V. During transitions, the voltage on any pin may undershoot to no less than -1.5 V or overshoot to no more than $V_{CC} + 1.5$ V, for periods of less than 20 ns.

^{3.} Block Mode, $V_{CC} = 5 \text{ V}$, 25°C .

Table 6. A.C. TEST CONDITIONS

Input Rise and Fall Times	≤ 50 ns		
Input Pulse Voltages	0.4 V to 2.4 V	$4.5 \text{ V} \le \text{V}_{CC} \le 5.5 \text{ V}$	
Timing Reference Voltages	0.8 V, 2.0 V	$4.5 \text{ V} \le \text{V}_{CC} \le 5.5 \text{ V}$	
Input Pulse Voltages	0.2 V _{CC} to 0.7 V _{CC}	$1.65 \text{ V} \le \text{V}_{CC} \le 4.5 \text{ V}$	
Timing Reference Voltages	0.5 V _{CC}	1.65 V ≤ V _{CC} ≤ 4.5 V	
Output Load	Current Source I _{OLmax} /I _{OHmax} ; CL = 100 pF		

- 4. These parameters are tested initially and after a design or process change that affects the parameter.
 5. t_{PUR} and t_{PUW} are the delays required from the time V_{CC} is stable until the specified operation can be initiated.

 $\textbf{Table 7. A.C. CHARACTERISTICS} \\ (V_{CC} = +1.8 \text{ V to } +5.5 \text{ V}, T_A = -40 ^{\circ}\text{C to } +125 ^{\circ}\text{C}, V_{CC} = +1.65 \text{ V to } +5.5 \text{ V}, T_A = -20 ^{\circ}\text{C to } +85 ^{\circ}\text{C unless otherwise specified.}) \\$

		V _{CC} < 4.5 V		V _{CC} > 4.5 V		
Symbol	Parameter	Min	Max	Min	Max	Units
t _{CSS}	CS Setup Time	50		50		ns
tcsH	CS Hold Time	0		0		ns
t _{DIS}	DI Setup Time	100		50		ns
t _{DIH}	DI Hold Time	100		50		ns
t _{PD1}	Output Delay to 1		0.25		0.1	μs
t _{PD0}	Output Delay to 0		0.25		0.1	μs
t _{HZ} (Note 6)	Output Delay to High-Z		100		100	ns
t _{EW}	Program/Erase Pulse Width		5		5	ms
t _{CSMIN}	Minimum CS Low Time	0.25		0.1		μs
t _{SKHI}	Minimum SK High Time	0.25		0.1		μs
t _{SKLOW}	Minimum SK Low Time	0.25		0.1		μs
t _{SV}	Output Delay to Status Valid		0.25		0.1	μs
SK _{MAX}	Maximum Clock Frequency	DC	2000	DC	4000	kHz

^{6.} This parameter is tested initially and after a design or process change that affects the parameter.

Table 8. INSTRUCTION SET

	Start		Address		D	ata	
Instruction	Bit	Opcode	x8	x16	x8	x16	Comments
READ	1	10	A10-A0	A9-A0			Read Address AN- A0
ERASE	1	11	A10-A0	A9-A0			Clear Address AN- A0
WRITE	1	01	A10-A0	A9-A0	D7-D0	D15-D0	Write Address AN- A0
EWEN	1	00	11XXXXXXXXX	11XXXXXXXX			Write Enable
EWDS	1	00	00XXXXXXXXX	00XXXXXXXX			Write Disable
ERAL*	1	00	10XXXXXXXXX	10XXXXXXXX			Clear All Addresses
WRAL*	1	00	01XXXXXXXXX	01XXXXXXXX	D7-D0	D15-D0	Write All Addresses

^{*}Not available at V_{CC} < 1.8 V

Device Operation

The CAT93C86B is a 16,384-bit nonvolatile memory intended for use with industry standard microprocessors. The CAT93C86B can be organized as either registers of 16 bits or 8 bits. When organized as X16, seven 13-bit instructions control the reading, writing and erase operations of the device. When organized as X8, seven 14-bit instructions control the reading, writing and erase operations of the device. The CAT93C86B operates on a single power supply and will generate on chip, the high voltage required during any write operation.

Instructions, addresses, and write data are clocked into the DI pin on the rising edge of the clock (SK). The DO pin is normally in a high impedance state except when reading data from the device, or when checking the ready/busy status after a write operation.

The ready/busy status can be determined after the start of a write operation by selecting the device (CS high) and polling the DO pin; DO low indicates that the write operation is not completed, while DO high indicates that the device is ready for the next instruction. If necessary, the DO pin may be placed back into a high impedance state during chip select by shifting a dummy "1" into the DI pin. The DO pin will enter the high impedance state on the falling edge of the clock (SK). Placing the DO pin into the high impedance state is recommended in applications where the DI pin and the DO pin are to be tied together to form a common DI/O pin.

The format for all instructions sent to the device is a logical "1" start bit, a 2-bit (or 4-bit) opcode, 10-bit address (an additional bit when organized X8) and for write operations a 16-bit data field (8-bit for X8 organizations).

Note: The Write, Erase, Write all and Erase all instructions require PE = 1. If PE is left floating, 93C86B is in Program Enabled mode. For Write Enable and Write Disable instruction PE = don't care.

Read

Upon receiving a READ command and an address (clocked into the DI pin), the DO pin of the CAT93C86B will come out of the high impedance state and, after sending an initial dummy zero bit, will begin shifting out the data addressed (MSB first). The output data bits will toggle on the rising edge of the SK clock and are stable after the specified time delay ($t_{\rm PD0}$ or $t_{\rm PD1}$).

After the initial data word has been shifted out and CS remains asserted with the SK clock continuing to toggle, the device will automatically increment to the next address and shift out the next data word in a sequential READ mode. As long as CS is continuously asserted and SK continues to toggle, the device will keep incrementing to the next address automatically until it reaches to the end of the address space, then loops back to address 0. In the sequential READ mode, only the initial data word is preceded by a dummy zero bit. All subsequent data words will follow without a dummy zero bit.

Write

After receiving a WRITE command, address and the data, the CS (Chip Select) pin must be deselected for a minimum of t_{CSMIN}. The falling edge of CS will start the self clocking clear and data store cycle of the memory location specified in the instruction. The clocking of the SK pin is not necessary after the device has entered the self clocking mode. The ready/busy status of the CAT93C86B can be determined by selecting the device and polling the DO pin. Since this device features Auto–Clear before write, it is NOT necessary to erase a memory location before it is written into.

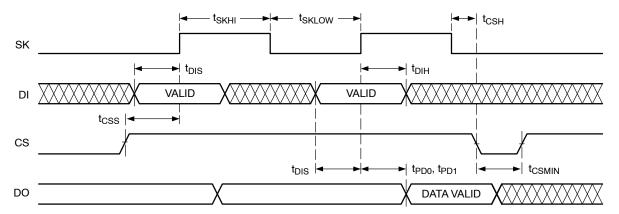


Figure 2. Synchronous Data Timing

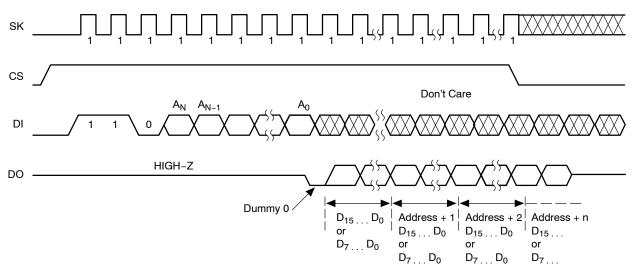


Figure 3. Read Instruction Timing

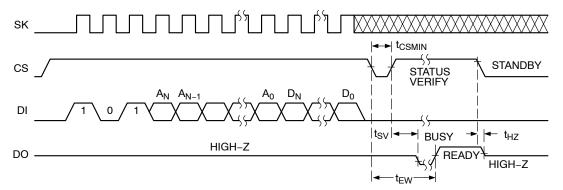


Figure 4. Write Instruction Timing

Erase

Upon receiving an ERASE command and address, the CS (Chip Select) pin must be deasserted for a minimum of $t_{\rm CSMIN}$. The falling edge of CS will start the self clocking clear cycle of the selected memory location. The clocking of the SK pin is not necessary after the device has entered the self clocking mode. The ready/busy status of the CAT93C86B can be determined by selecting the device and polling the DO pin. Once cleared, the content of a cleared location returns to a logical "1" state.

Erase/Write Enable and Disable

The CAT93C86B powers up in the write disable state. Any writing after power-up or after an EWDS (write disable) instruction must first be preceded by the EWEN (write enable) instruction. Once the write instruction is enabled, it will remain enabled until power to the device is removed, or the EWDS instruction is sent. The EWDS instruction can be used to disable all CAT93C86B write and clear instructions, and will prevent any accidental writing or clearing of the device. Data can be read normally from the device regardless of the write enable/disable status.

Erase All

Upon receiving an ERAL command, the CS (Chip Select) pin must be deselected for a minimum of t_{CSMIN}. The falling edge of CS will start the self clocking clear cycle of all memory locations in the device. The clocking of the SK pin is not necessary after the device has entered the self clocking mode. The ready/busy status of the CAT93C86B can be determined by selecting the device and polling the DO pin. Once cleared, the contents of all memory bits return to a logical "1" state.

Write All

Upon receiving a WRAL command and data, the CS (Chip Select) pin must be deselected for a minimum of t_{CSMIN}. The falling edge of CS will start the self clocking data write to all memory locations in the device. The clocking of the SK pin is not necessary after the device has entered the self clocking mode. The ready/busy status of the CAT93C86B can be determined by selecting the device and polling the DO pin. It is not necessary for all memory locations to be cleared before the WRAL command is executed.

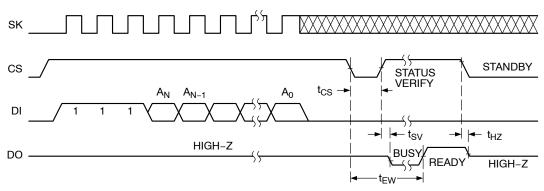
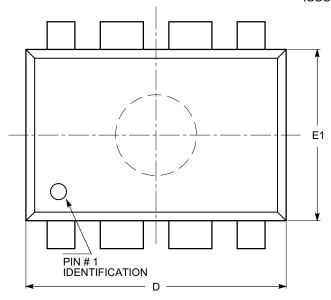


Figure 5. Erase Instruction Timing

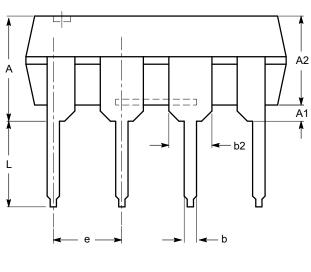
PACKAGE DIMENSIONS

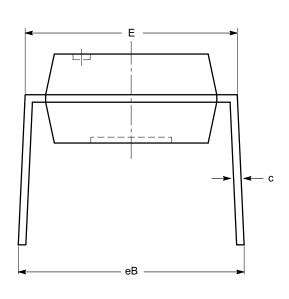
PDIP-8, 300 mils CASE 646AA-01 ISSUE A



SYMBOL	MIN	NOM	MAX	
Α			5.33	
A1	0.38			
A2	2.92	3.30	4.95	
b	0.36	0.46	0.56	
b2	1.14	1.52	1.78	
С	0.20	0.25	0.36	
D	9.02	9.27	10.16	
Е	7.62	7.87	8.25	
E1	6.10	6.35	7.11	
е	2.54 BSC			
eB	7.87		10.92	
L	2.92	3.30	3.80	

TOP VIEW





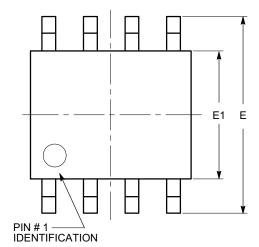
SIDE VIEW

END VIEW

- (1) All dimensions are in millimeters.
- (2) Complies with JEDEC MS-001.

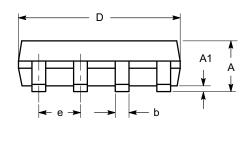
PACKAGE DIMENSIONS

SOIC 8, 150 mils CASE 751BD-01 ISSUE O

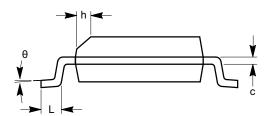


SYMBOL	MIN	NOM	MAX
Α	1.35		1.75
A1	0.10		0.25
b	0.33		0.51
С	0.19		0.25
D	4.80		5.00
Е	5.80		6.20
E1	3.80		4.00
е		1.27 BSC	
h	0.25		0.50
L	0.40		1.27
θ	0°		8°

TOP VIEW



SIDE VIEW

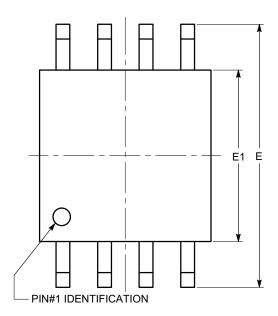


END VIEW

- (1) All dimensions are in millimeters. Angles in degrees.(2) Complies with JEDEC MS-012.

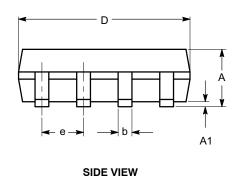
PACKAGE DIMENSIONS

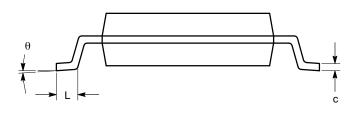
SOIC-8, 208 mils CASE 751BE-01 ISSUE O



SYMBOL	MIN	NOM	MAX
А			2.03
A1	0.05		0.25
b	0.36		0.48
С	0.19		0.25
D	5.13		5.33
E	7.75		8.26
E1	5.13		5.38
е		1.27 BSC	
L	0.51		0.76
θ	0°		8°

TOP VIEW



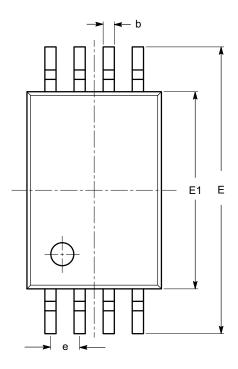


END VIEW

- (1) All dimensions are in millimeters. Angles in degrees.(2) Complies with EIAJ EDR-7320.

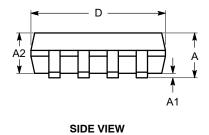
PACKAGE DIMENSIONS

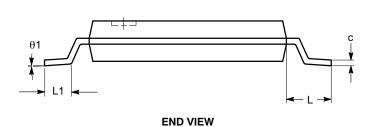
TSSOP8, 4.4x3 CASE 948AL-01 ISSUE O



SYMBOL	MIN	NOM	MAX
Α			1.20
A1	0.05		0.15
A2	0.80	0.90	1.05
b	0.19		0.30
С	0.09		0.20
D	2.90	3.00	3.10
Е	6.30	6.40	6.50
E1	4.30	4.40	4.50
е	0.65 BSC		
L	1.00 REF		
L1	0.50 0.60 0		0.75
θ	0°		8°





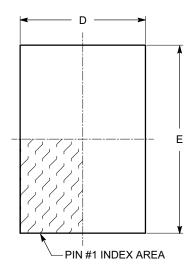


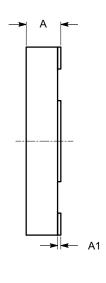
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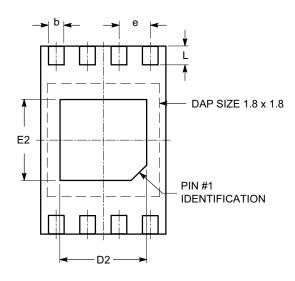
PACKAGE DIMENSIONS

UDFN8, 2x3 EXTENDED PAD

CASE 517AZ-01 ISSUE O





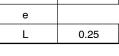


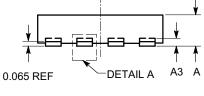
IOP	VIEW
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SIDE VIEW

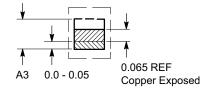
BOTTOM VIEW

SYMBOL	MIN NOM		MAX
Α	0.45	0.50	0.55
A1	0.00 0.02		0.05
А3	0.127 REF		
b	0.20	0.25	0.30
D	1.95	2.00	2.05
D2	1.35 1.40		1.45
Е	2.95	3.00	3.05
E2	1.25	1.30	1.35
е	0.50 REF		
L	0.25 0.30 0.35		





FRONT VIEW

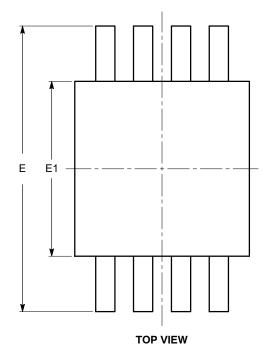


DETAIL A

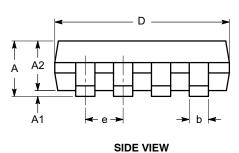
- (1) All dimensions are in millimeters.
- (2) Refer JEDEC MO-236/MO-252.

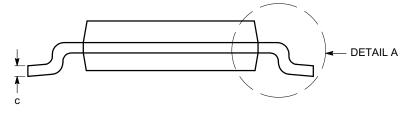
PACKAGE DIMENSIONS

MSOP 8, 3x3 CASE 846AD-01 ISSUE O

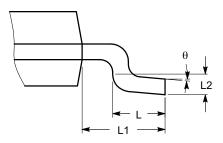


SYMBOL	MIN NOM		MAX
Α			1.10
A1	0.05	0.10	0.15
A2	0.75 0.85		0.95
b	0.22		0.38
С	0.13		0.23
D	2.90	3.00	3.10
E	4.80	4.90	5.00
E1	2.90 3.00		3.10
е	0.65 BSC		
L	0.40 0.60		0.80
L1	0.95 REF		
L2	0.25 BSC		
θ	0° 6°		





END VIEW

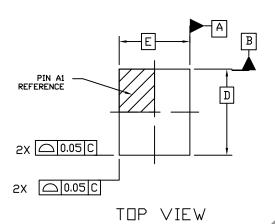


- (1) All dimensions are in millimeters. Angles in degrees.(2) Complies with JEDEC MO-187.

DETAIL A

PACKAGE DIMENSIONS

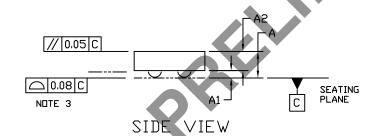
WLCSP 6, 0.96 x 1.17 CASE TBD ISSUE O

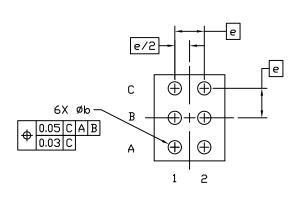


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE SPHERICAL CROWNS OF THE SOLDER BALLS.

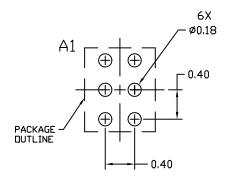
	MILLIMETERS		
DIM	MIN.	MAX.	
Α	-	0.41	
A1	0.08	0.12	
A2	0.26 REF		
۵	0.16	0.20	
D	1.17 BSC		
E	0.96 BSC		
e	0.40 BSC		





BOTTOM VIEW

RECOMMENDED MOUNTING FOOTPRINT



ORDERING INFORMATION

Order Number	Specific Device Marking	Package Type	Temperature Range	Lead Finish	Shipping
CAT93C86BLI-G	93C86D	PDIP-8	I = Industrial (-40°C to +85°C)	NiPdAu	Tube, 50 Units / Tube
CAT93C86BLE-G	93C86D	PDIP-8	E = Extended (-40°C to +125°C)	NiPdAu	Tube, 50 Units / Tube
CAT93C86BVI-GT3	93C86D	SOIC-8, JEDEC	I = Industrial (-40°C to +85°C)	NiPdAu	Tape & Reel, 3,000 Units / Reel
CAT93C86BVI-GT3L	93C86D	SOIC-8, JEDEC	I = Industrial -20°C to +85°C	NiPdAu	Tape & Reel, 3,000 Units / Reel
CAT93C86BVE-GT3	93C86D	SOIC-8, JEDEC	E = Extended (-40°C to +125°C)	NiPdAu	Tape & Reel, 3,000 Units / Reel
CAT93C86BYI-GT3	M86D	TSSOP-8	I = Industrial (-40°C to +85°C)	NiPdAu	Tape & Reel, 3,000 Units / Reel
CAT93C86BYI-GT3L	M86D	TSSOP-8	I = Industrial (-20°C to +85°C)	NiPdAu	Tape & Reel, 3,000 Units / Reel
CAT93C86BYE-GT3	M86D	TSSOP-8	E = Extended (-40°C to +125°C)	NiPdAu	Tape & Reel, 3,000 Units / Reel
CAT93C86BHU4I-GT3	M4U	UDFN-8	I = Industrial (-40°C to +85°C)	NiPdAu	Tape & Reel, 3,000 Units / Reel
CAT93C86BHU4E-GT3	M4U	UDFN-8	E = Extended (-40°C to +125°C)	NiPdAu	Tape & Reel, 3,000 Units / Reel
CAT93C86BC6ATR (Note 9)	M4	WLCSP-6	I = Industrial (-40°C to +85°C)	SnAgCu	Tape & Reel, 5,000 Units / Reel
CAT93C86BZI-GT3	M4	MSOP-8	I = Industrial (-40°C to +85°C)	NiPdAu	Tape & Reel, 3,000 Units / Reel
CAT93C86BZE-GT3	M4	MSOP-8	E = Extended (-40°C to +125°C)	NiPdAu	Tape & Reel, 3,000 Units / Reel
CAT93C86BXI-T2	93C86D	SOIC-8, EIAJ	I = Industrial (-40°C to +85°C)	Matte-Tin	Tape & Reel, 2,000 Units / Reel
CAT93C86BXE-T2	93C86D	SOIC-8, EIAJ	E = Extended (-40°C to +125°C)	Matte-Tin	Tape & Reel, 2,000 Units / Reel

- All packages are RoHS-compliant (Lead-free, Halogen-free).
- 8. The standard lead finish is NiPdAu.
- 9. Preliminary. Please contact factory for availability.
- 10. For additional package and temperature options, please contact your nearest ON Semiconductor Sales office.
- 11. For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.
- 12. For detailed information and a breakdown of device nomenclature and numbering systems, please see the ON Semiconductor Device Nomenclature document, TND310/D, available at www.onsemi.com

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